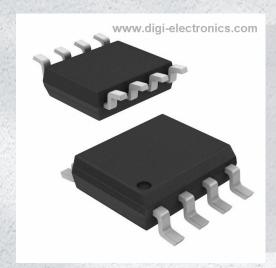


FDFS2P102 Datasheet



https://www.DiGi-Electronics.com

DiGi Electronics Part Number FDFS2P102-DG

Manufacturer onsemi

Manufacturer Product Number FDFS2P102

Description MOSFET P-CH 20V 3.3A 8SOIC

Detailed Description P-Channel 20 V 3.3A (Ta) 900mW (Ta) Surface Mou

nt 8-SOIC



Tel: +00 852-30501935

RFQ Email: Info@DiGi-Electronics.com

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Purchase and inquiry

Manufacturer Product Number: Manufacturer: FDFS2P102 onsemi Product Status: Series: Obsolete FET Type: Technology: P-Channel MOSFET (Metal Oxide) Drain to Source Voltage (Vdss): Current - Continuous Drain (Id) @ 25°C: 20 V 3.3A (Ta) Drive Voltage (Max Rds On, Min Rds On): Rds On (Max) @ Id, Vgs: 4.5V, 10V 125mOhm @ 3.3A, 10V Vgs(th) (Max) @ Id: Gate Charge (Qg) (Max) @ Vgs: 2V @ 250μA 10 nC @ 10 V Vgs (Max): Input Capacitance (Ciss) (Max) @ Vds: ±20V 270 pF @ 10 V FET Feature: Power Dissipation (Max): Schottky Diode (Isolated) 900mW (Ta) Operating Temperature: Mounting Type: -55°C ~ 150°C (TJ) **Surface Mount** Supplier Device Package: Package / Case: 8-SOIC 8-SOIC (0.154", 3.90mm Width) Base Product Number: FDFS2

Environmental & Export classification

Moisture Sensitivity Level (MSL):	REACH Status:
1 (Unlimited)	REACH Unaffected
ECCN:	HTSUS:
EAR99	8541.21.0095



October 2000

FDFS2P102

Integrated P-Channel MOSFET and Schottky Diode

General Description

The FDFS2P102 combines the exceptional performance of Fairchild's high cell density MOSFET with a very low forward voltage drop Schottky barrier rectifier in an SO-8 package.

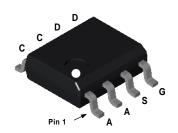
This device is designed specifically as a single package solution for DC to DC converters. It features a fast switching, low gate charge MOSFET with very low on-state resistance. The independently connected Schottky diode allows its use in a variety of DC/DC converter topologies.

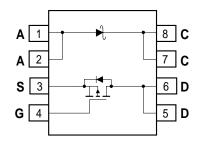
Applications

- DC/DC converters
- Load Switch
- Motor Drives

Features

- -3.3 A, -20 V. $R_{DS(ON)} = 0.125~\Omega$ @ $V_{GS} = -10~V$ $R_{DS(ON)} = 0.200~\Omega$ @ $V_{GS} = -4.5~V$.
- $V_F < 0.39 V @ 1 A (T_J = 125 {}^{o}C)$. $V_F < 0.47 V @ 1 A$. $V_F < 0.58 V @ 2 A$.
- Schottky and MOSFET incorporated into single power surface mount SO-8 package.
- Electrically independent Schottky and MOSFET pinout for design flexibility.





MOSFET Maximum Ratings TA=25°C unless otherwise noted

Symbol	ol Parameter		Ratings	Units V	
V _{DSS}	Drain-Source Voltage		-20		
V _{GSS}	Gate-Source Voltage		±20	V	
I _D	Drain Current - Continuous	(Note 1a)	-3.3	А	
	- Pulsed		-20		
P _D	Power Dissipation for Dual Operation		2	W	
	Power Dissipation for Single Operation	(Note 1a)	1.6		
		(Note 1b)	1		
		(Note 1c)	0.9		
T _J , T _{STG}	Operating and Storage Temperature Range		-55 to +150	°C	

Schottky Diode Maximum Ratings TA=25°C unless otherwise noted

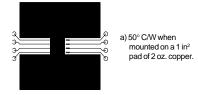
V_{RRM}	Repetitive Peak Reverse Voltage		20	V
Io	Average Forward Current	(Note 1a)	1	Α

Package Marking and Ordering Information

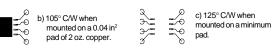
Device Marking	Device	Reel Size	Tape Width	Quantity
FDFS2P102	FDFS2P102	13	12mm	2500 units

Symbol	Parameter	Test C	onditions	Min	Тур	Max	Units
Off Char	acteristics						
BV _{DSS}	Drain-Source Breakdown Voltage	$V_{GS} = 0 \text{ V}, I_D = 0 \text{ V}$	= -250 μA	-20			V
oss	Zero Gate Voltage Drain Current	$V_{DS} = -16 \text{ V},$	*			-1	μΑ
	j ,	$V_{GS} = 0 V$	$T_J = 55^{\circ}C$			-10	
GSSF	Gate-Body Forward Leakage	$V_{GS} = 20 \text{ V}, \text{ V}$	_{DS} = 0 V			100	nA
GSSR	Gate-Body Reverse Leakage	$V_{GS} = -20 \text{ V},$	$V_{DS} = 0 V$			-100	nA
On Char	acteristics (Note 2)						
/ _{GS(th)}	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_{D}$	= -250 µA	-1	-1.4	-2	V
R _{DS(on)}	Static Drain-Source On-Resistance	$V_{GS} = -10 \text{ V, I}$			0.100	0.125	Ω
20(01)		$V_{GS} = -4.5 \text{ V},$			0.167	0.2	1
D(on)	On-State Drain Current	V _{GS} = -10 V, \		-10			Α
I FS	Forward Transconductance	V _{DS} = -10 V, I	_D = -3.3 A		5		S
Ovnamic	: Characteristics						
o jiss	Input Capacitance	V _{DS} = -10 V, \	$V_{GS} = 0 \text{ V},$		270		pF
Coss	Output Capacitance	f = 1.0 MHz		150		pF	
O _{rss}	Reverse Transfer Capacitance	1			45		pF
	g Characteristics (Note 2)				•	•	•
d(on)	Turn-On Delay Time	V _{DD} = -15 V.	In = -1 A		8	16	ns
r	Turn-On Rise Time	$V_{GS} = -10 \text{ V}, R_{GEN} = 6 \Omega$ 7 17				14	ns
d(off)	Turn-Off Delay Time					27	ns
f	Turn-Off Fall Time					1.8	ns
Q_g	Total Gate Charge				7	1.0	nC
- g	Total Gate Glidige	$V_{GS} = -10 \text{ V},$					1.0
Drain-So	ource Diode Characteristics ar	nd Maximur	n Ratings				
S	Maximum Continuous Drain-Source Di					-1.3	Α
/ _{SD}	Drain-Source Diode Forward Voltage	$V_{GS} = 0 \text{ V}, I_{S} = 0 \text{ V}$	= -1.3 A (Note 2)		-0.8	-1.2	V
Schottky	/ Diode Characteristics						
R	Reverse Leakage	V _R = 20 V	$T_{\perp} = 25^{\circ}C$			250	uA
T.		1	$T_{J} = 125^{\circ}C$			18	mA
/ _F	Forward Voltage	I _F = 1 A	$T_{J} = 25^{\circ}C$			0.47	V
			$T_{J} = 125^{\circ}C$			0.39	
		I _F = 2 A	$T_J = 25^{\circ}C$			0.58	
			$T_J = 125^{\circ}C$			0.53	<u> </u>
<u>Thermal</u>	Characteristics						_
A _L S	Thermal Resistance, Junction-to-Ambient (Note 1a)				78		
R JC	Thermal Resistance, Junction-to-Case (Note 1)				40		

^{1:} R_{BJA} is the sum of the junction-to-case and case-to-ambient resistance where the case thermal reference is defined as the solder mounting surface of the drain pins. $R_{\theta JC}$ is guaranteed by design while $R_{\theta CA}$ is determined by the user's board design.







Scale 1: 1 on letter size paper

^{2:} Pulse Test: Pulse Width \leq 300 μ s, Duty Cycle \leq 2.0%

Typical Characteristics

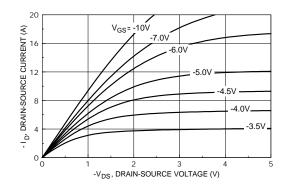


Figure 1. On-Region Characteristics.

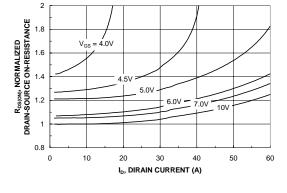


Figure 2. On-Resistance Variation with Drain Current and Gate Voltage.

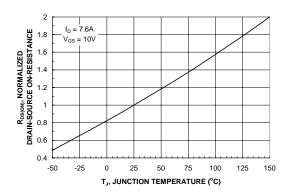


Figure 3. On-Resistance Variation with Temperature.

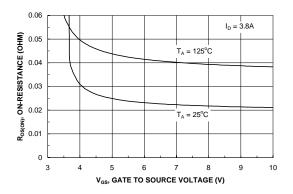


Figure 4. On-Resistance Variation with Gate-to-Source Voltage.

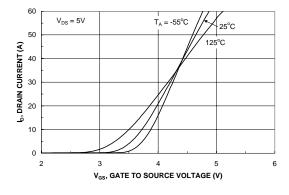


Figure 5. Transfer Characteristics.

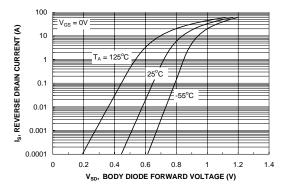
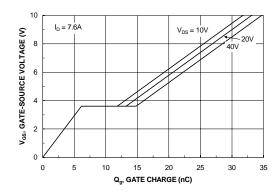


Figure 6. Body Diode Forward Voltage Variation with Source Current and Temperature.

Typical Characteristics (continued)



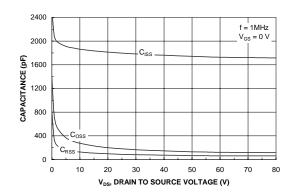
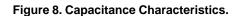
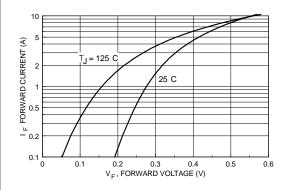


Figure 7. Gate-Charge Characteristics.





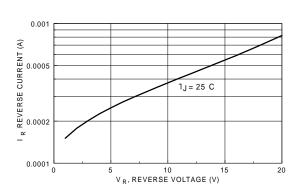


Figure 9. Schottky Diode Forward Voltage.

Figure 10. Schottky Diode Reverse Current.

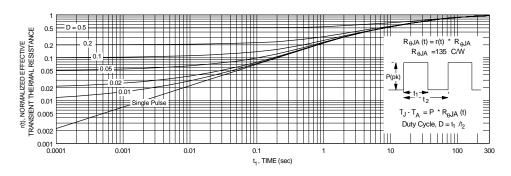


Figure 11. Transient Thermal Response Curve.

Thermal characterization performed using the conditions described in Note 1c. Transient themal response will change depending on the circuit board design.

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